Temperature Measurement by a Nanoscale Electron Probe using Energy Gain and Loss Spectroscopy

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Correct thermal management is essential for the microelectronics industry [1]. Accuracy requires the use of a microscopy technique that is able to map the local temperature of a material with high spatial resolution. Local temperature measurements with nanoscale spatial resolution have recently been achieved by tracking the energy shifts of bulk plasmons as a function of temperature in a scanning transmission electron microscope (STEM) [2]. Another approach to measure temperature is based on a concept that originated in the 1960s and consists of determining the ratio of energy gains to energy losses of a fast electron beam interacting with low energy excitation such as phonons in a material [3-5].

Here, we use the phonon approach to measure the local temperature of nanomaterials by electron energy-gain and energy loss spectroscopy in a monochromated aberration-corrected STEM [6]. The experiments were performed using ORNL's Nion HERMESTM operated at 60 kV. Nanoflakes of hexagonal boron nitride (h-BN) were deposited on a Protochips Fusion MEMS-based heating chip, where the temperature was varied from ~320 K to ~ 1600 K. Figure 1a shows the energy gain and loss peaks of an optical phonon mode of the h-BN as a function of temperature, which were obtained in an aloof scattering geometry. Figure 1b shows the temperature obtained using the principle of detailed balance [7]. The experiments in this study show that by detecting gain peaks, the local temperature of a material can be obtained directly, based purely on statistical principles, and indirectly (using empirical fits). Combined with theory, energy-gain spectroscopy also enables the study of anharmonic effects in materials by probing phonons in the electron microscope at different temperatures [8].

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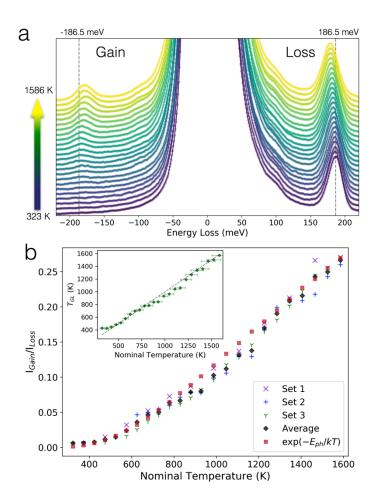


Figure 1. Electron energy-loss and energy gain spectra of h-BN as a function of temperature (a) Spectra acquired as function of temperature from 323 K to 1586 K, with an average increment of 55 K. (b) Gain and loss phonon peak intensity (I_{Gain}/I_{Loss}) ratios of three different sets of measurements performed at different times (and the respective average). Inset in (b) shows the temperatures obtained by the principle of detailed balance T_{GL} against the nominal temperature. Figure adapted from Ref. 6.